

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/941,748	TAKEO ET AL.
	Examiner Craig W. Kronenthal	Art Unit 2623

SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
382	128	9/14/2005	CK
378	207	9/14/2005	CK
382	132	9/14/2005	oic